

| | | | |
|-----------------------------------|---------------------------------------|---|-------------|
| Notice of References Cited | Application/Control No. 09/942,620 | Applicant(s)/Patent Under Reexamination NAKAMURA ET AL. | |
| | Examiner Kristie Shingles | Art Unit 2141 | Page 1 of 1 |

U.S. PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Name | Classification |
|---|---|--|-----------------|----------------------|----------------|
| * | A | US-6,539,386 | 03-2003 | Athavale et al. | 707/10 |
| * | B | US-6,016,504 | 01-2000 | Arnold et al. | 709/200 |
| * | C | US-4,897,867 | 01-1990 | Foster et al. | 379/93.12 |
| * | D | US-5,974,451 | 10-1999 | Simmons, C. Thomas | 709/218 |
| * | E | US-5,668,953 | 09-1997 | Sloo, Marshall Allan | 705/1 |
| * | F | US-6,438,632 | 08-2002 | Kikugawa, Satoru | 710/100 |
| * | G | US-6,484,196 | 11-2002 | Maurille, Mithras C. | 709/206 |
| * | H | US-6,347,307 | 02-2002 | Sandhu et al. | 705/35 |
| | I | US- | | | |
| | J | US- | | | |
| | K | US- | | | |
| | L | US- | | | |
| | M | US- | | | |

FOREIGN PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Country | Name | Classification |
|---|---|--|-----------------|---------|------|----------------|
| | N | | | | | |
| | O | | | | | |
| | P | | | | | |
| | Q | | | | | |
| | R | | | | | |
| | S | | | | | |
| | T | | | | | |

NON-PATENT DOCUMENTS

| * | | Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) |
|---|---|---|
| | U | |
| | V | |
| | W | |
| | X | |

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.